MOSFET – Power, Single, P-Channel, Enhancement Mode, SOIC-8

-5.4 A, -20 V

Features

- High Density Power MOSFET with Ultra Low R_{DS(on)} Providing Higher Efficiency
- Miniature SOIC-8 Surface Mount Package Saves Board Space
- Diode Exhibits High Speed with Soft Recovery
- I_{DSS} Specified at Elevated Temperature
- Drain-to-Source Avalanche Energy Specified
- Mounting Information for the SOIC-8 Package is Provided
- These Devices are Pb-Free and are RoHS Compliant
- NVMS Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable

Applications

• Power Management in Portable and Battery-Powered Products, i.e.: Computers, Printers, PCMCIA Cards, Cellular & Cordless Telephones

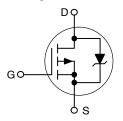


ON Semiconductor®

http://onsemi.com

V _{DSS} R _{DS(ON)} TYP		I _D MAX	
-20 V	26 m Ω @ –4.5 V	-5.4 A	

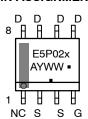
Single P-Channel



MARKING DIAGRAM & PIN ASSIGNMENT



Α



E5P02 = Specific Device Code

c = Blank or S

= Assembly Location

′ = Year

V = Work Week

= Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMS5P02R2G	SOIC-8 (Pb-Free)	2500 / Tape & Reel
NVMS5P02R2G	SOIC-8 (Pb-Free)	2500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage	V _{DSS}	-20	V
Drain-to-Gate Voltage (R _{GS} = 1.0 mΩ)	V_{DGR}	-20	V
Gate-to-Source Voltage - Continuous	V _{GS}	±10	V
Thermal Resistance – Junction–to–Ambient (Note 1) Total Power Dissipation @ T _A = 25°C Continuous Drain Current @ 25°C Continuous Drain Current @ 70°C Maximum Operating Power Dissipation Maximum Operating Drain Current Pulsed Drain Current (Note 4)	R _{θJA} PD ID PD ID ID	50 2.5 -7.05 -5.62 1.2 -4.85 -28	°C/W W A A W A
Thermal Resistance – Junction–to–Ambient (Note 2) Total Power Dissipation @ T _A = 25°C Continuous Drain Current @ 25°C Continuous Drain Current @ 70°C Maximum Operating Power Dissipation Maximum Operating Drain Current Pulsed Drain Current (Note 4)	R _{θJA} PD ID PD ID ID	85 1.47 -5.40 -4.30 0.7 -3.72 -20	°C/W W A A W A
Thermal Resistance – Junction-to-Ambient (Note 3) Total Power Dissipation @ T _A = 25°C Continuous Drain Current @ 25°C Continuous Drain Current @ 70°C Maximum Operating Power Dissipation Maximum Operating Drain Current Pulsed Drain Current (Note 4)	R _{θJA} P _D I _D I _D I _D I _D I _D I _D	159 0.79 -3.95 -3.15 0.38 -2.75 -12	°C/W W A A W A
Operating and Storage Temperature Range	T _J , T _{stg}	-55 to +150	°C
Single Pulse Drain–to–Source Avalanche Energy – Starting T_J = 25°C (V_{DD} = -20 Vdc, V_{GS} = -5.0 Vdc, Peak I_L = -8.5 Apk, L = 10 mH, R_G = 25 Ω)	E _{AS}	360	mJ
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	T _L	260	°C

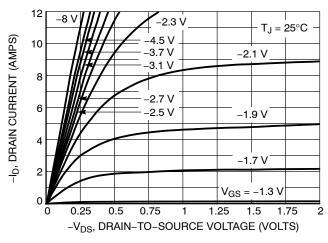
Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- Mounted onto a 2" square FR-4 Board (1" sq. 2 oz Cu 0.06" thick single sided), t ≤ 10 seconds.
 Mounted onto a 2" square FR-4 Board (1" sq. 2 oz Cu 0.06" thick single sided), t = steady state.
 Minimum FR-4 or G-10 PCB, t = Steady State.
 Pulse Test: Pulse Width = 300 μs, Duty Cycle = 2%.

ELECTRICAL CHARACTERISTICS ($T_C = 25$ °C unless otherwise noted) (Note 5)

Ch	aracteristic	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Volta ($V_{GS} = 0$ Vdc, $I_D = -250$ μ Adc) Temperature Coefficient (Positive)	age	V _{(BR)DSS}	-20 -	_ _15	- -	Vdc mV/°C
Zero Gate Voltage Drain Current $(V_{DS} = -16 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, T (V_{DS} = -16 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, T (V_{DS} = -20 \text{ Vdc}, V_{GS} = -20 \text{ Vdc}, T (V_{DS} = -20 \text{ Vdc}, V_{GS} = -20 \text{ Vdc}, T (V_{DS} = -20 \text{ Vdc}, V_{GS} = -20 \text{ Vdc}, T (V_{DS} = -20 \text{ Vdc}, V_{GS} = -20 \text{ Vdc}, T (V_{DS} = -20 \text{ Vdc}, V_{GS} = -20 \text{ Vdc}, T (V_{DS} = -20 \text{ Vdc}, V_{GS} = -20 \text{ Vdc}, T (V_{DS} = -20 \text{ Vdc}, V_{GS} = -20 \text{ Vdc}, T (V_{DS} = -20 \text{ Vdc}, V_{GS} = -20 \text{ Vdc}, T (V_{DS} = -20 \text{ Vdc}, V_{GS} = -20 \text{ Vdc}, T$	_J = 125°C)	I _{DSS}	- - -	- - -0.2	-1.0 -10 -	μAdc
Gate-Body Leakage Current (V _{GS} = -10 Vdc, V _{DS} = 0 Vdc)		I _{GSS}	-	-	-100	nAdc
Gate-Body Leakage Current (V _{GS} = +10 Vdc, V _{DS} = 0 Vdc)		I _{GSS}	_	_	100	nAdc
ON CHARACTERISTICS			•	•	•	*
Gate Threshold Voltage $(V_{DS} = V_{GS}, I_D = -250 \mu Adc)$ Temperature Coefficient (Negative)	V _{GS(th)}	-0.65 -	-0.9 2.9	-1.25 -	Vdc mV/°C
Static Drain-to-Source On-State $(V_{GS} = -4.5 \text{ Vdc}, I_D = -5.4 \text{ Adc})$ $(V_{GS} = -2.5 \text{ Vdc}, I_D = -2.7 \text{ Adc})$		R _{DS(on)}	-	0.026 0.037	0.033 0.048	Ω
Forward Transconductance (V _{DS} =	= -9.0 Vdc, I _D = -5.4 Adc)	9FS	-	15	-	Mhos
YNAMIC CHARACTERISTICS						
Input Capacitance		C _{iss}	-	1375	1900	pF
Output Capacitance	$(V_{DS} = -16 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, $ f = 1.0 MHz)	C _{oss}	-	510	900	
Reverse Transfer Capacitance		C _{rss}	_	200	380	
WITCHING CHARACTERISTICS	(Notes 6 & 7)					
Turn-On Delay Time		t _{d(on)}	-	18	35	ns
Rise Time	$(V_{DD} = -16 \text{ Vdc}, I_D = -1.0 \text{ Adc},$	t _r	-	25	50	
Turn-Off Delay Time	$V_{GS} = -4.5 \text{ Vdc},$ $R_G = 6.0 \Omega)$	t _{d(off)}	-	70	125	
Fall Time		t _f	_	55	100	
Turn-On Delay Time		t _{d(on)}	_	22	-	ns
Rise Time	$(V_{DD} = -16 \text{ Vdc}, I_D = -5.4 \text{ Adc},$	t _r	_	70	-]
Turn-Off Delay Time	$V_{GS} = -4.5 \text{ Vdc},$ $R_G = 6.0 \Omega)$	t _{d(off)}	ı	65	-	
Fall Time		t _f	-	90	-	
Total Gate Charge	(V _{DS} = -16 Vdc,	Q _{tot}	-	20	35	nC
Gate-Source Charge	$V_{GS} = -10 \text{ Vdc},$ $V_{GS} = -4.5 \text{ Vdc},$	Q _{gs}	-	4.0	-	
Gate-Drain Charge	$I_D = -5.4 \text{ Adc}$	Q _{gd}	-	7.0	-	
SODY-DRAIN DIODE RATINGS (N	lote 6)			•	I.	1
Diode Forward On-Voltage	$(I_S = -5.4 \text{ Adc}, V_{GS} = 0 \text{ V})$ $(I_S = -5.4 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, T_J = 125^{\circ}\text{C})$	V_{SD}	-	-0.95 -0.72	-1.25 -	Vdc
Reverse Recovery Time		t _{rr}	ı	40	75	ns
	$(I_S = -5.4 \text{ Adc}, V_{GS} = 0 \text{ Vdc},$ $dI_S/dt = 100 \text{ A}/\mu\text{s})$	ta	-	20	-	
	J 4,77	t _b	-	20	-	
Reverse Recovery Stored Charge		Q _{RR}	-	0.03	-	μС

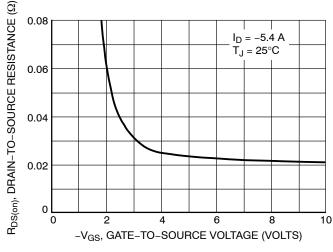
- 5. Handling precautions to protect against electrostatic discharge is mandatory. 6. Indicates Pulse Test: Pulse Width = 300 μ s max, Duty Cycle = 2%. 7. Switching characteristics are independent of operating junction temperature.



 $V_{DS} \ge -10 \text{ V}$ -I_D, DRAIN CURRENT (AMPS) 8 6 100°C 25°C $T_J = -55^{\circ}C$ 0 -V_{GS}, GATE-TO-SOURCE VOLTAGE (VOLTS)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



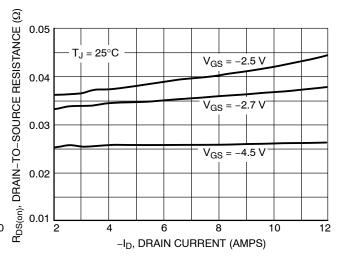
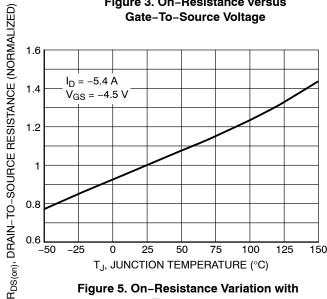


Figure 3. On-Resistance versus Gate-To-Source Voltage

Figure 4. On-Resistance versus Drain Current and Gate Voltage



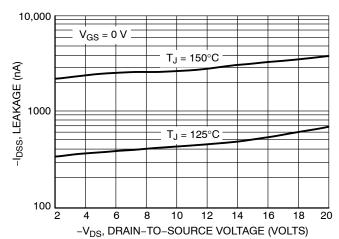
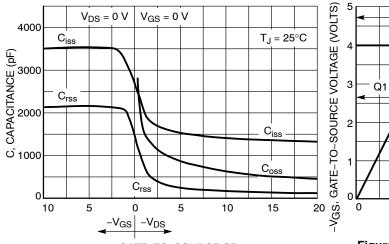


Figure 5. On-Resistance Variation with **Temperature**

Figure 6. Drain-To-Source Leakage Current versus Voltage



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

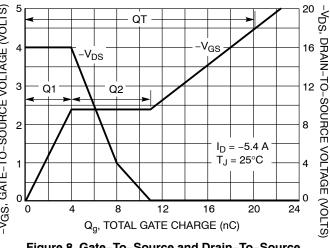
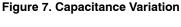


Figure 8. Gate-To-Source and Drain-To-Source Voltage versus Total Charge



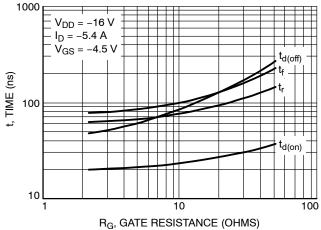


Figure 9. Resistive Switching Time Variation versus Gate Resistance

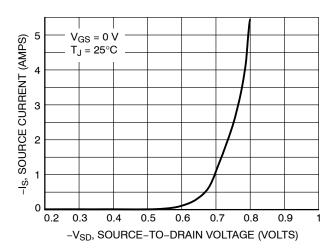


Figure 10. Diode Forward Voltage versus Current

DRAIN-TO-SOURCE DIODE CHARACTERISTICS

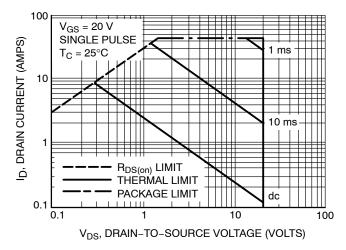


Figure 11. Maximum Rated Forward Biased Safe Operating Area

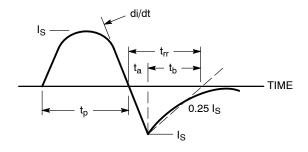


Figure 12. Diode Reverse Recovery Waveform

TYPICAL ELECTRICAL CHARACTERISTICS

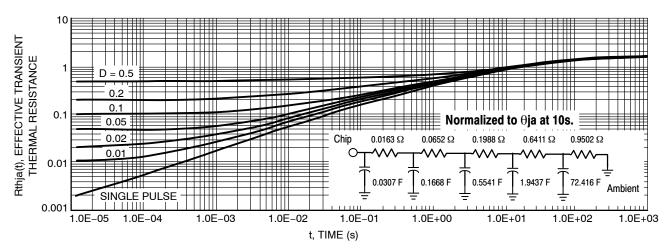


Figure 13. Thermal Response





SOIC-8 NB CASE 751-07 **ISSUE AK**

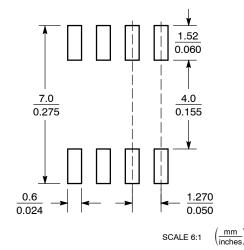
DATE 16 FEB 2011



- NOTES:
 1. DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982.
 CONTROLLING DIMENSION: MILLIMETER.
- DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION.
- MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE
- DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.
- 751-01 THRU 751-06 ARE OBSOLETE. NEW STANDARD IS 751-07.

	MILLIMETERS		INCHES	
DIM	MIN MAX		MIN	MAX
Α	4.80	5.00	0.189	0.197
В	3.80	3.80 4.00		0.157
С	1.35 1.75		0.053	0.069
D	0.33 0.51		0.013	0.020
G	1.27 BSC		0.050 BSC	
Н	0.10 0.25		0.004	0.010
7	0.19 0.25		0.007	0.010
K	0.40 1.27		0.016	0.050
M	0 ° 8 °		0 °	8 °
N	0.25	0.50	0.010	0.020
S	5.80 6.20		0.228	0.244

SOLDERING FOOTPRINT*



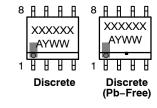
^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code = Assembly Location = Wafer Lot = Year = Work Week W

= Pb-Free Package



XXXXXX = Specific Device Code = Assembly Location Α = Year ww = Work Week = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

STYLES ON PAGE 2

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SOIC-8 NB CASE 751-07 ISSUE AK

DATE 16 FEB 2011

STYLE 1: PIN 1. EMITTER 2. COLLECTOR 3. COLLECTOR 4. EMITTER 5. EMITTER 6. BASE 7. BASE 8. EMITTER	STYLE 2: PIN 1. COLLECTOR, DIE, #1 2. COLLECTOR, #1 3. COLLECTOR, #2 4. COLLECTOR, #2 5. BASE, #2 6. EMITTER, #2 7. BASE, #1 8. EMITTER, #1	STYLE 3: PIN 1. DRAIN, DIE #1 2. DRAIN, #1 3. DRAIN, #2 4. DRAIN, #2 5. GATE, #2 6. SOURCE, #2 7. GATE, #1 8. SOURCE, #1	STYLE 4: PIN 1. ANODE 2. ANODE 3. ANODE 4. ANODE 5. ANODE 6. ANODE 7. ANODE 8. COMMON CATHODE
STYLE 5: PIN 1. DRAIN 2. DRAIN 3. DRAIN 4. DRAIN 5. GATE 6. GATE 7. SOURCE 8. SOURCE	7. BASE, #1 8. EMITTER, #1 STYLE 6: PIN 1. SOURCE 2. DRAIN 3. DRAIN 4. SOURCE 5. SOURCE 6. GATE 7. GATE 8. SOURCE	STYLE 7: PIN 1. INPUT 2. EXTERNAL BYPASS 3. THIRD STAGE SOURCE 4. GROUND 5. DRAIN 6. GATE 3 7. SECOND STAGE Vd 8. FIRST STAGE Vd	STYLE 8: PIN 1. COLLECTOR, DIE #1 2. BASE, #1 3. BASE. #2
STYLE 9: PIN 1. EMITTER, COMMON 2. COLLECTOR, DIE #1 3. COLLECTOR, DIE #2 4. EMITTER, COMMON 5. EMITTER, COMMON 6. BASE, DIE #2 7. BASE, DIE #1 8. EMITTER, COMMON	STYLE 10: PIN 1. GROUND 2. BIAS 1 3. OUTPUT 4. GROUND 5. GROUND 6. BIAS 2 7. INPUT 8. GROUND	STYLE 11: PIN 1. SOURCE 1 2. GATE 1 3. SOURCE 2 4. GATE 2 5. DRAIN 2 6. DRAIN 2 7. DRAIN 1 8. DRAIN 1	STYLE 12: PIN 1. SOURCE 2. SOURCE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN
STYLE 13: PIN 1. N.C. 2. SOURCE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN	STYLE 14: PIN 1. N-SOURCE 2. N-GATE 3. P-SOURCE 4. P-GATE 5. P-DRAIN 6. P-DRAIN 7. N-DRAIN 8. N-DRAIN	STYLE 15: PIN 1. ANODE 1 2. ANODE 1 3. ANODE 1 4. ANODE 1 5. CATHODE, COMMON 6. CATHODE, COMMON 7. CATHODE, COMMON 8. CATHODE, COMMON	STYLE 16: PIN 1. EMITTER, DIE #1 2. BASE, DIE #1 3. EMITTER, DIE #2 4. BASE, DIE #2 5. COLLECTOR, DIE #2 6. COLLECTOR, DIE #2 7. COLLECTOR, DIE #1 8. COLLECTOR, DIE #1
STYLE 17: PIN 1. VCC 2. V2OUT 3. V1OUT 4. TXE 5. RXE 6. VEE 7. GND 8. ACC	STYLE 18: PIN 1. ANODE 2. ANODE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. CATHODE 8. CATHODE	STYLE 19: PIN 1. SOURCE 1 2. GATE 1 3. SOURCE 2 4. GATE 2 5. DRAIN 2 6. MIRROR 2 7. DRAIN 1 8. MIRROR 1	STYLE 20: PIN 1. SOURCE (N) 2. GATE (N) 3. SOURCE (P) 4. GATE (P) 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN
5. RXE 6. VEE 7. GND 8. ACC STYLE 21: PIN 1. CATHODE 1 2. CATHODE 2 3. CATHODE 3 4. CATHODE 4 5. CATHODE 5 6. COMMON ANODE 7. COMMON ANODE 8. CATHODE 6	STYLE 22: PIN 1. I/O LINE 1 2. COMMON CATHODE/VCC 3. COMMON CATHODE/VCC 4. I/O LINE 3 5. COMMON ANODE/GND 6. I/O LINE 4 7. I/O LINE 5 8. COMMON ANODE/GND	STYLE 23: PIN 1. LINE 1 IN 2. COMMON ANODE/GND 3. COMMON ANODE/GND 4. LINE 2 IN 5. LINE 2 OUT 6. COMMON ANODE/GND 7. COMMON ANODE/GND 8. LINE 1 OUT	STYLE 24: PIN 1. BASE 2. EMITTER 3. COLLECTOR/ANODE 4. COLLECTOR/ANODE 5. CATHODE 6. CATHODE 7. COLLECTOR/ANODE 8. COLLECTOR/ANODE
STYLE 25: PIN 1. VIN 2. N/C 3. REXT 4. GND 5. IOUT 6. IOUT 7. IOUT 8. IOUT	STYLE 26: PIN 1. GND 2. dv/dt 3. ENABLE 4. ILIMIT 5. SOURCE 6. SOURCE 7. SOURCE 8. VCC	STYLE 27: PIN 1. ILIMIT 2. OVLO 3. UVLO 4. INPUT+ 5. SOURCE 6. SOURCE 7. SOURCE 8. DRAIN	STYLE 28: PIN 1. SW_TO_GND 2. DASIC_OFF 3. DASIC_SW_DET 4. GND 5. V MON 6. VBULK 7. VBULK 8. VIN
STYLE 29: PIN 1. BASE, DIE #1 2. EMITTER, #1 3. BASE, #2 4. EMITTER, #2 5. COLLECTOR, #2 6. COLLECTOR, #2 7. COLLECTOR, #1 8. COLLECTOR, #1	STYLE 30: PIN 1. DRAIN 1 2. DRAIN 1 3. GATE 2 4. SOURCE 2 5. SOURCE 1/DRAIN 2 6. SOURCE 1/DRAIN 2 7. SOURCE 1/DRAIN 2 8. GATE 1		

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